

Search Notes

Application/Control No.

10/615,298

Examiner

Ivan H. Carpio

Applicant(s)/Patent under
Reexamination

FURUKAWA ET AL.

Art Unit

2841

SEARCHED

Class	Subclass	Date	Examiner
361	760	8/30/2005	IC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text searched substrate, component, conductive paste,	8/30/2005	IC
Text searched electronic, semiconductor, surface acoustic wave filter, radio frequency, switch	8/30/2005	IC
Forward and backward searched relevant hits	8/31/2005	IC